

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/571,195	LEE ET AL.
	Examiner	Art Unit
	Patricia Leith	1655

**SEARCHED**

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE updated	6/27/2008	PL
Inventor name search updated EAST/PALM	6/27/2008	PL
STN updated (fil reg/Indexer BIOSCIENCE & napralert - approx. 76 databases)	6/27/2008	PL